

## New technique to help produce nextgeneration photonic chips

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Ultrafast photomodulation spectroscopy with the sample in the middle and the small blue spot on the sample, which shows the actual pump-light used in the method. Credit: University of Southampton

Researchers from the University of Southampton have developed a new technique to help produce more reliable and robust next generation photonic chips.



Photonic chips made from silicon will play a major role in future optical networks for worldwide data traffic. The high <u>refractive index</u> of silicon makes <u>optical structures</u> the size of a fraction of the diameter of a human hair possible. Squeezing more and more optical structures for light distribution, modulation, detection and routing into smaller chip areas allows for higher data rates at lower fabrication costs.

As the complexity of optical chips increases, testing and characterising such chips becomes more difficult. Light traveling in the chip is confined in the silicon, that is, it cannot be 'seen' or measured from the outside.

Southampton researchers have now developed a new method, which will help solve this problem, to find out at which time the light in the chip is at which position. The <u>technique</u>, called Ultrafast photomodulation spectroscopy (UPMS), uses ultraviolet laser pulses of femtosecond duration to change the refractive index of silicon in a tiny area on the <u>photonic chip</u>.

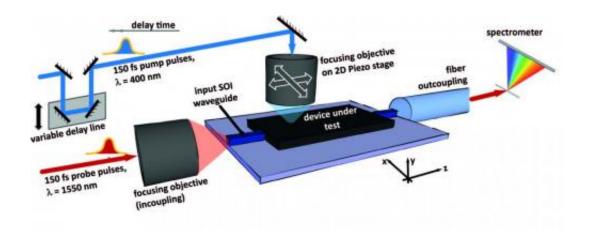
Non-contact characterization tools like UPMS are vital for scientist designing complex photonic chips. The UPMS technique is fast and robust and has the potential to be used for industrial testing in the photonics industry.

The research is published in the latest issue of the journal *Nature Photonics*.

Dr Roman Bruck, from Physics and Astronomy at the University of Southampton and lead author of the study, says: "Monitoring the transmission of the chip while the refractive index is locally changed gives a precise picture of how the light flows through it. This allows testing of individual optical elements on the chip, a crucial step in the design optimisation to ensure its flawless operation. Because the changes



induced by the technique are fully reversible, this testing method is nondestructive and after testing, the <u>chip</u> can be used for its intended application."



Concept of ultrafast photomodulation spectroscopy. Credit: University of Southampton

The research team, from Physics and Astronomy and the Optoelectronics Research Centre (ORC) at the University, expects to establish the technique as a standard characterisation tool, making photonic chips under development more reliable and bringing them into the market quicker. The work has been funded by the Engineering and Physical Sciences Research Council (EPSRC).

**More information:** *Nature Photonics*, <u>DOI:</u> <u>10.1038/NPHOTON.2014.274</u>

Provided by University of Southampton



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